

<b>Notice of References Cited</b>	Application/Control No. 10/714,839	Applicant(s)/Patent Under Reexamination TAKAHASHI ET AL.	
	Examiner Alain L. Bashore	Art Unit 1762	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,912,063	06-1999	Osawa et al.	428/847.1
	B	US-5,512,350	04-1996	Ryoke et al.	428/141
	C	US-6,017,605	01-2000	Yamazaki et al.	428/842
	D	US-5,506,064	04-1996	Tamai et al.	428/842.4
	E	US-2003/0207484	11-2003	Nishikawa, Takao	438/31
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.